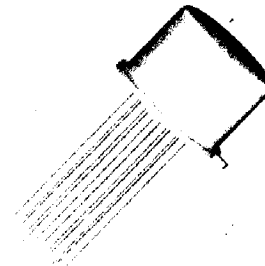


DUAL MATCHED NPN SILICON TRANSISTOR

2N2060 / 2N2060A

- Matched Dual NPN Transistors
- Low Power
- Hermetically Sealed TO-77 Metal Package
- High Reliability Screening Options Available



ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise stated)

V _{CEO}	Collector – Emitter Voltage	60V	
V _{CER}	Collector – Emitter Voltage	80V	
V _{CBO}	Collector – Base Voltage	100V	
V _{EBO}	Emitter – Base Voltage	7V	
I _C	Continuous Collector Current	500mA	
P _D	Total Power Dissipation at T _A = 25°C Derate Above 25°C T _C = 25°C Derate Above 25°C	Per Side	Total Device
		540 mW	600 mW
		3.08 mW/°C	3.48 mW/°C
		1.5W	2.12W
		8.6 mW/°C	12.1 mW/°C
T _J	Junction Temperature Range	-65 to +200°C	
T _{stg}	Storage Temperature Range	-65 to +200°C	



ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise stated)

Symbols	Parameters	Test Conditions	Min	Typ	Max	Units
I_{CBO}	Collector-Cut-Off Current	$V_{CB} = 80\text{V}$			0.002	μA
		$I_E = 0$			10	
		$T_A = 150^\circ\text{C}$				
I_{EBO}	Emitter Cut-off Current	$V_{BE} = 5\text{V}$			2.0	nA
$V_{(BR)CBO}$	Collector-Base Breakdown Voltage	$I_C = 100\mu\text{A}$			100	V
$V_{(BR)EBO}$	Emitter-Base Breakdown Voltage	$I_E = 100\mu\text{A}$			7	
$V_{(BR)CER}^{(1)}$	Collector - Emitter Breakdown Voltage	$I_C = 100\text{mA}$			80	
$V_{(BR)CEO}^{(1)}$	Collector - Emitter Breakdown Voltage	$I_C = 30\text{mA}$			60	
$V_{BE(sat)}$	Base-Emitter Saturation Voltage	$I_C = 50\text{mA}$			0.9	
$V_{CE(sat)}$	Collector - Emitter Saturation Voltage	$I_C = 50\text{mA}$			0.6	
		2N2060A				
		$I_B = 5\text{mA}$				
		2N2060				
		$I_B = 5\text{mA}$			1.2	
H_{FE}	Forward-current transfer ratio	$I_C = 10\mu\text{A}$	$V_{CE} = 5\text{V}$	25		75
		$I_C = 100\mu\text{A}$	$V_{CE} = 5\text{V}$	30		90
		$I_C = 1.0\text{mA}$	$V_{CE} = 5\text{V}$	40		120
		$I_C = 10\text{mA}$	$V_{CE} = 5\text{V}$	50		150

DYNAMIC CHARACTERISTICS

f_T	Current Gain Bandwidth Product	$I_C = 50\text{mA}$	$V_{CE} = 10\text{V}$	60			MHz
		$f = 20\text{MHz}$					
h_{fe}	Small-Signal Current Gain	$I_C = 1.0\text{mA}$	$V_{CE} = 5\text{V}$	50		150	-
		$f = 1.0\text{KHz}$					
$h_{ie}^{(3)}$	Input Impedance	$I_C = 1.0\text{mA}$	$V_{CE} = 5\text{V}$	1000		4000	Ω
		$f = 1.0\text{KHz}$					
$h_{ib}^{(3)}$	Input Impedance	$I_C = 1.0\text{mA}$	$V_{CB} = 10\text{V}$	20		30	
		$f = 1.0\text{KHz}$					
C_{obo}	Output Capacitance	$V_{CB} = 10\text{V}$	$I_E = 0$			15	pF
		$f = 1.0\text{MHz}$					
C_{ibo}	Input Capacitance	$V_{BE} = 0.5\text{V}$	$I_C = 0$			85	pF
		$f = 1.0\text{MHz}$					

Notes

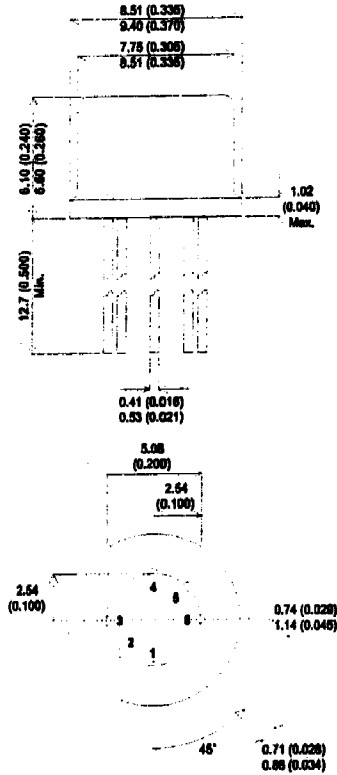
- (1) Pulse Width $\leq 300\mu\text{s}$, $\delta \leq 2\%$
- (2) The lowest H_{FE} reading is taken as H_{FE1} for this ratio
- (3) Parameter by design only

MATCHING CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise stated)

Symbols	Parameters	Test Conditions		Min	Typ	Max	Units
		I_C	V_{CE}				
H_{FE1}/H_{FE2}	DC Current Gain Ratio ^m	$I_C = 100\mu\text{A}$	$V_{CE} = 5\text{V}$	0.9		1.0	-
		$I_C = 1.0\text{mA}$	$V_{CE} = 5\text{V}$	0.9		1.0	
$ V_{BE1} - V_{BE2} $	Base - Emitter Voltage Differential	$I_C = 100\mu\text{A}$	$V_{CE} = 5\text{V}$			3.0	mV
		$I_C = 1.0\text{mA}$	$V_{CE} = 5\text{V}$			5.0	
$\Delta \frac{(V_{BE1} - V_{BE2})}{\Delta T}$	Base - Emitter Voltage Differential Change Due To Temperature	$I_C = 1.0\text{mA}$	$V_{CE} = 5\text{V}$			5.0	$\mu\text{V}/^\circ\text{C}$
		$T_A = -55^\circ\text{C}$ to $+125^\circ\text{C}$					

MECHANICAL DATA

Dimensions in mm (inches)



TO-77 (MO-002AF) METAL PACKAGE

- PIN 1 - Collector
- PIN 2 - Base
- PIN 3 - Emitter
- PIN 4 - Emitter
- PIN 5 - Base
- PIN 6 - Collector